





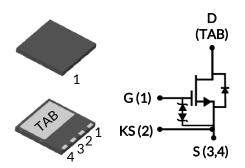








# UF3SC065030D8S



Part Number	Package	Marking
UF3SC065030D8S	DFN8X8-4L	UF3SC065030D8S









### 650V-34mΩ SiC FET

Rev. B, January 2020

### Description

This SiC FET device is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows for a true "drop-in replacement" to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the DFN8X8-4L package, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads , and any application requiring standard gate drive.

#### **Features**

- Typical on-resistance R<sub>DS(on),typ</sub> of 34mΩ
- Maximum operating temperature of 150°C
- Excellent reverse recovery
- Low gate charge
- Low intrinsic capacitance
- ESD protected, HBM class 2
- DFN8X8-4L package for faster switching, clean gate waveforms

### Typical applications

- EV charging
- PV inverters
- Switch mode power supplies
- Power factor correction modules
- Motor drives
- Induction heating













### **Maximum Ratings**

Parameter Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	$V_{DS}$		650	V
Gate-source voltage	$V_{GS}$	DC	-25 to +25	V
Continuous drain current <sup>1</sup>	I <sub>D</sub>	T <sub>C</sub> < 134°C	18	Α
Pulsed drain current <sup>2</sup>	I <sub>DM</sub>	T <sub>C</sub> = 25°C	160	Α
Single pulsed avalanche energy <sup>3</sup>	E <sub>AS</sub>	L=15mH, I <sub>AS</sub> =4A	120	mJ
Power dissipation	P <sub>tot</sub>	T <sub>C</sub> = 25°C	179	W
Maximum junction temperature	$T_{J,max}$		150	°C
Operating and storage temperature	$T_J, T_{STG}$		-55 to 150	°C
Reflow soldering temperature	$T_{solder}$	reflow MSL 3	260	°C

- 1. Limited by bondwires
- 2. Pulse width  $t_p$  limited by  $T_{J,max}$
- 3. Starting  $T_J = 25^{\circ}C$

#### **Thermal Characteristics**

Parameter	Symbol	Test Conditions	Value			Units
			Min	Тур	Max	Offics
Thermal resistance, junction-to-case	$R_{ heta$ JC			0.54	0.7	°C/W













# Electrical Characteristics (T<sub>J</sub> = +25°C unless otherwise specified)

### Typical Performance - Static

Parameter	Symbol	Test Conditions		Units		
			Min	Тур	Max	UIIILS
Drain-source breakdown voltage	BV <sub>DS</sub>	$V_{GS}$ =0V, $I_D$ =1mA	650			V
Total drain leakage current		V <sub>DS</sub> =650V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C		6	150	- μΑ
	I <sub>DSS</sub>	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V, T <sub>J</sub> =150°C		20		
Total gate leakage current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, T <sub>J</sub> =25°C, V <sub>GS</sub> =-20V / +20V		6	±20	μА
Drain-source on-resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =12V, I <sub>D</sub> =20A, T <sub>J</sub> =25°C		34	42	
		V <sub>GS</sub> =12V, I <sub>D</sub> =20A, T <sub>J</sub> =125°C		48		mΩ
		$V_{GS}$ =12V, $I_{D}$ =20A, $T_{J}$ =150°C		55		
Gate threshold voltage	$V_{G(th)}$	$V_{DS}$ =5V, $I_D$ =10mA	4	5	6	V
Gate resistance	$R_{G}$	f=1MHz, open drain		4.5		Ω

# Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions		I I I alika		
			Min	Тур	Max	- Units
Diode continuous forward current <sup>1</sup>	I <sub>S</sub>	T <sub>C</sub> < 134°C			18	А
Diode pulse current <sup>2</sup>	I <sub>S,pulse</sub>	T <sub>C</sub> =25°C			160	А
Forward voltage	V <sub>FSD</sub>	V <sub>GS</sub> =0V, I <sub>F</sub> =20A, T <sub>J</sub> =25°C		1.45	1.65	_ V
		V <sub>GS</sub> =0V, I <sub>F</sub> =20A, T <sub>J</sub> =150°C		1.65		
Reverse recovery charge	Q <sub>rr</sub>	$V_R$ =400V, $I_F$ =20A, $V_{GS}$ =-5V, $R_{G\_EXT}$ =10 $\Omega$		242		nC
Reverse recovery time	t <sub>rr</sub>	di/dt=1230A/μs, T <sub>J</sub> =25°C		32		ns
Reverse recovery charge	Q <sub>rr</sub>	$V_R$ =400V, $I_F$ =20A, $V_{GS}$ =-5V, $R_{G_EXT}$ =10 $\Omega$		229		nC
Reverse recovery time	t <sub>rr</sub>	di/dt=1230A/μs, Τ <sub>J</sub> =150°C		30		ns













# Typical Performance - Dynamic

Parameter	Symbol	Test Conditions	Value			Units
			Min	Тур	Max	Units
Input capacitance	$C_{iss}$	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V		1500		
Output capacitance	$C_{oss}$	f=100kHz		320		pF
Reverse transfer capacitance	$C_{rss}$	1-100KH2		2.3		
Effective output capacitance, energy related	$C_{oss(er)}$	$V_{DS}$ =0V to 400V, $V_{GS}$ =0V		230		pF
Effective output capacitance, time related	$C_{oss(tr)}$	$V_{DS}$ =0V to 400V, $V_{GS}$ =0V		520		pF
C <sub>OSS</sub> stored energy	E <sub>oss</sub>	V <sub>DS</sub> =400V, V <sub>GS</sub> =0V		18.5		μЈ
Total gate charge	$Q_G$	- V <sub>DS</sub> =400V, I <sub>D</sub> =20A, -		43		nC
Gate-drain charge	$Q_{GD}$	$V_{DS} = -5V \text{ to } 12V$		11		
Gate-source charge	$Q_{GS}$	V <sub>GS</sub> - 3V to 12V		19		
Turn-on delay time	$t_{d(on)}$	V <sub>DS</sub> =400V, I <sub>D</sub> =20A, Gate		23		ns - - - - - - -
Rise time	$t_r$	Driver =-5V to +12V,		19		
Turn-off delay time	t <sub>d(off)</sub>	Turn-on $R_{G,EXT}$ =8.5 $\Omega$ , Turn-off $R_{G,EXT}$ =22 $\Omega$ Inductive Load, FWD: same device with $V_{GS}$ = -5V, $R_{G}$ = 10 $\Omega$ , $T_{J}$ =25°C		43		
Fall time	t <sub>f</sub>			11		
Turn-on energy	E <sub>ON</sub>			175		
Turn-off energy	E <sub>OFF</sub>			19		
Total switching energy	E <sub>TOTAL</sub>			194		
Turn-on delay time	t <sub>d(on)</sub>	V <sub>DS</sub> =400V, I <sub>D</sub> =20A, Gate		21		- ns
Rise time	$t_r$	Driver =-5V to +12V, Turn-on $R_{G,EXT}$ =8.5 $\Omega$ , Turn-off $R_{G,EXT}$ =22 $\Omega$ Inductive Load, FWD: same device with $V_{GS}$ = -5V, $R_{G}$ = 10 $\Omega$ , $T_{J}$ =150°C		18		
Turn-off delay time	t <sub>d(off)</sub>			44		
Fall time	t <sub>f</sub>			11		
Turn-on energy	E <sub>ON</sub>			157		
Turn-off energy	E <sub>OFF</sub>			20		μЈ
Total switching energy	E <sub>TOTAL</sub>			177		





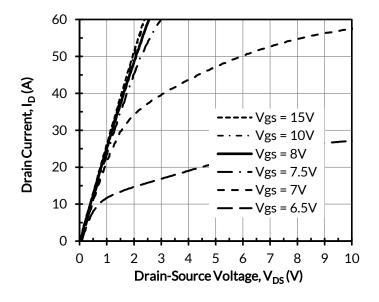








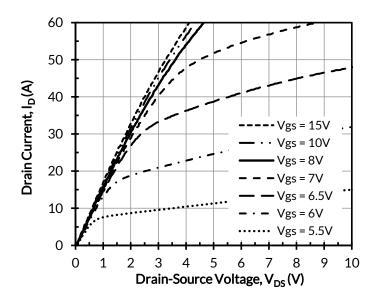
#### **Typical Performance Diagrams**



60 50 Drain Current, I<sub>D</sub> (A) 40 30 Vgs = 15V - Vgs = 10V 20 • Vgs = 8V - Vgs = 7V 10 Vgs = 6.5V2 10 0 1 5 Drain-Source Voltage, V<sub>DS</sub> (V)

Figure 1. Typical output characteristics at  $T_J = -55$ °C, tp < 250 $\mu$ s

Figure 2. Typical output characteristics at  $T_J = 25$ °C, tp < 250 $\mu$ s



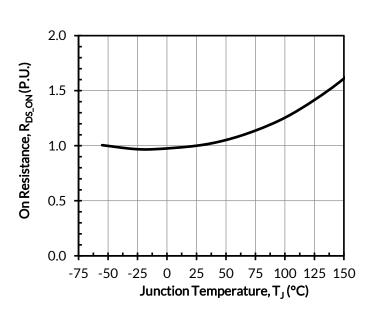


Figure 3. Typical output characteristics at  $T_J$  = 150°C, tp < 250 $\mu$ s

Figure 4. Normalized on-resistance vs. temperature at  $V_{GS}$  = 12V and  $I_D$  = 20A



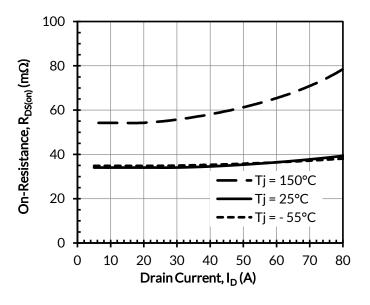








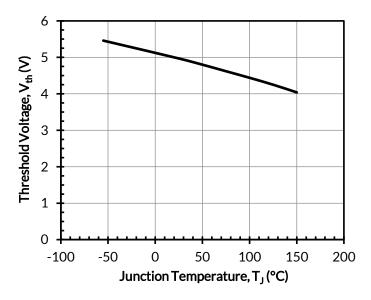




Tj = -55°C Tj = 25°C **-** Tj = 150°C Drain Current, I<sub>D</sub> (A) Gate-Source Voltage,  $V_{GS}(V)$ 

Figure 5. Typical drain-source on-resistances at  $V_{GS}$  = 12V

Figure 6. Typical transfer characteristics at  $V_{DS}$  = 5V



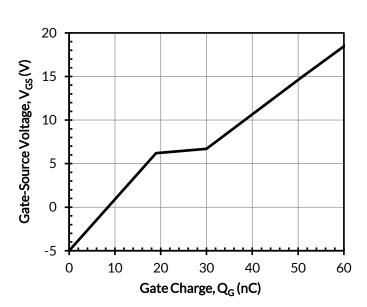


Figure 7. Threshold voltage vs. junction temperature at  $V_{DS}$  = 5V and  $I_{D}$  = 10mA

Figure 8. Typical gate charge at  $V_{DS}$  = 400V and  $I_{D}$  = 20A



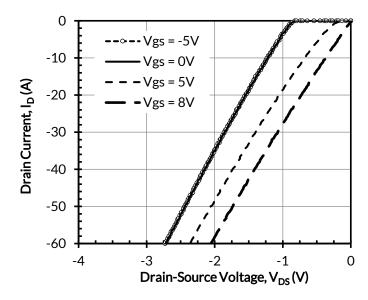


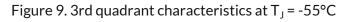












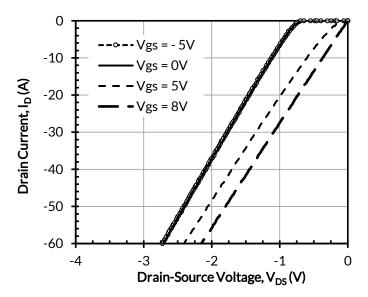


Figure 10. 3rd quadrant characteristics at T<sub>J</sub> = 25°C

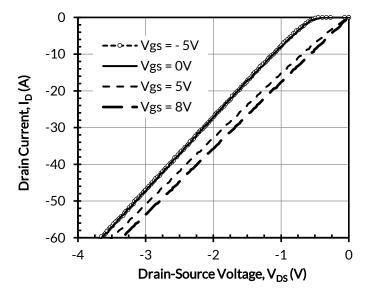


Figure 11. 3rd quadrant characteristics at  $T_J = 150$ °C

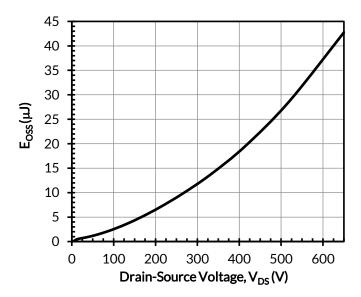


Figure 12. Typical stored energy in  $C_{OSS}$  at  $V_{GS} = 0V$ 













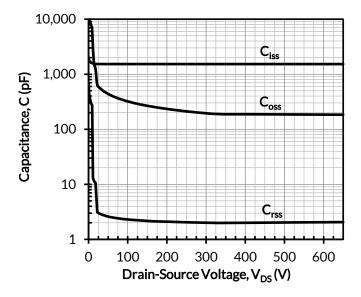
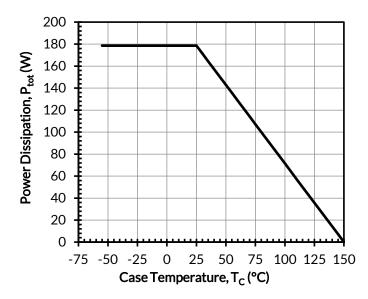


Figure 13. Typical capacitances at f = 100kHz and  $V_{GS}$  = 0V

Figure 14. DC drain current derating



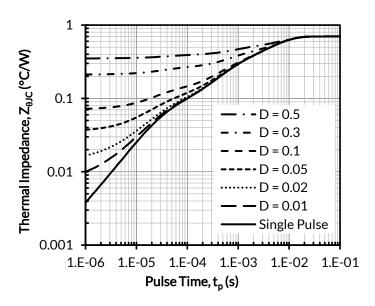


Figure 15. Total power dissipation

Figure 16. Maximum transient thermal impedance













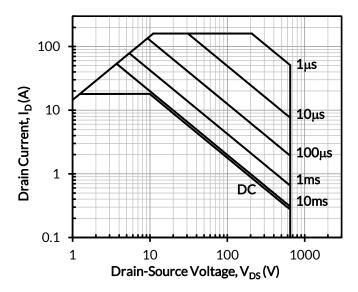


Figure 17. Safe operation area at  $T_C = 25$ °C, D = 0, Parameter  $t_p$ 

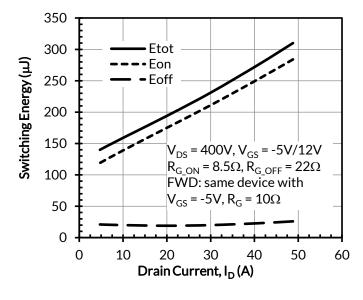


Figure 18. Clamped inductive switching energy vs. drain current at  $T_1 = 25$ °C

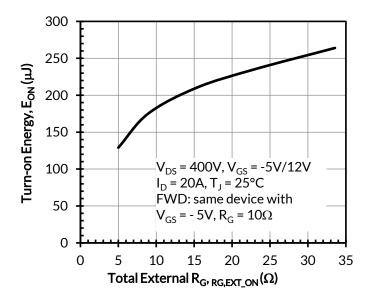


Figure 19. Clamped inductive switching turn-on energy vs.  $R_{\text{G,EXT\_ON}}$ 

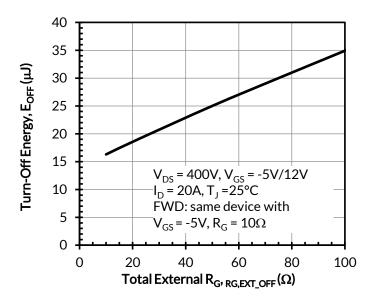


Figure 20. Clamped inductive switching turn-off energy vs.  $R_{G,\text{EXT OFF}}$ 



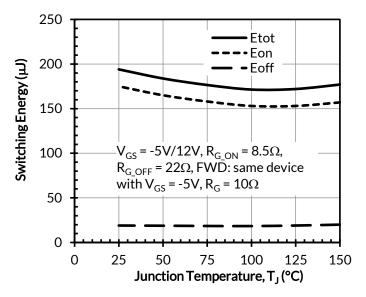












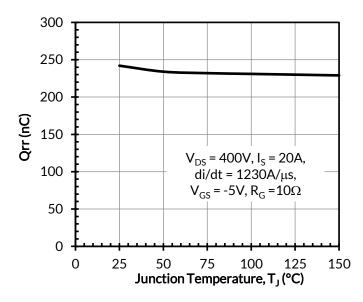


Figure 21. Clamped inductive switching energy vs. junction temperature at  $V_{DS}$  = 400V and  $I_D$  = 20A

Figure 22. Reverse recovery charge Qrr vs. junction temperature

#### **Applications Information**

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ( $R_{\rm DS(on)}$ ), output capacitance ( $C_{\rm oss}$ ), gate charge ( $Q_{\rm G}$ ), and reverse recovery charge (Qrr) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see www.unitedsic.com.

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